Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/041,761	YOON ET AL.	
Examiner	Art Unit	
Hung Q. Dang	2621	

SEARCHED				
Class	Subclass	Date	Examiner	
386	125	10/2/2007	HQD ·	
369	47.21, 59.25, 275.4	10/2/2007	HQD	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		3033 - 488		
		** 145		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
STIC Plus Search	8/2/2006	НОД
Inventos' Names Search	7/25/2006	HQD
USPAT; US-PGPUB; USOCR; EPO; JPO; DERWENT; IBM_TDB (see Search History attached)	8/10/2006- 8/16/2006	HQD
consulted with Thai Tran	12/8/2006	НОД
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